Search Notes

;			
ı			

Application/Control No.

Applicant(s)/Patent Under Reexamination

10016223

CHANG ET AL.

Art Unit

Examiner AJAY BHATIA

2145

SEARCHED				
Class		Subclass	Date	Examiner
709	227		11/21/2008	AB

SEARCH NOTES			
Search Notes	Date	Examiner	
East Search	11/21/2008	AB	
Google Scholar	11/21/2008	AB	

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	

U.S. Patent and Trademark Office Part of Paper No.: 20081121